

**INFORMATION DISCLOSURE
CITATION**


Atty. Docket No.: 53868US04

Serial No.: 10/791,064

Applicant(s): JATHAN D. EDWARDS

Filing Date: 03/02/2004

Group: ~~2655~~

2627

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	SubClass	Filing Date If Appropriate
/PWH/	3,565,978	02/71	Folger et al.			
↓	4,150,398	04/79	Kojima et al.			
↓	4,304,806	12/81	Anderson et al.			
↓	4,308,337	12/81	Roach et al.			
↓	4,374,077	02/83	Kerfeld			
↓	4,519,065	05/85	Lewis et al.			
↓	4,619,804	10/86	Leonard et al.			
/PWH/	4,650,735	03/87	De Laat			

FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub- Class	Translation	
						Yes	No
/PWH/	0 418 897 A2	03/91	European Pat. Office				
↓	0 444 367 A1	09/91	European Pat. Office				
↓	DE 41 40 712 A1	10/92	Germany			Abstract Only	
↓	60-029950	02/85	Japan			Abstract Only	
/PWH/	64-023440	01/89	Japan			X	

OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)

/PWH/ ↓	F. Dill et al., "Characterization of Postive Photoresist," IEEE Transactions on Electron Devices, Vol. ED-22, No. 7, July 1975, pp. 445-452
	E. O. Keizer, "VideoDisc Mastering," RCA Review, Vol. 39, No. 1, March 1978, pp. 60-86
↓ /PWH/	P. Trefonas III et al., "New Principle for Image Enhancement in Single Layer Positive Photoresists," SPIE Vol. 771, <i>Advances in Resist Technology and Processing IV</i> , March 1987, pp. 194-210
	S. Nakamura et al., "High Density Recording for Magneto-optical Disk Drive," IEEE Transactions on Magnetics, Vol. 34, No. 2, March 1998, pp. 411-413

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Date Considered

06/25/2007

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Examiner Initial	Document Number	Date	Name	Class	SubClass	Filing Date If Appropriate
/PWH/	5,096,563	03/92	Yoshizawa et al.			
	5,149,607	09/92	De Graaf et al.			
	5,325,353	06/94	Sasaki et al.			
	5,381,394	01/95	Yanagawa			
	5,436,885	07/95	Okumura et al.			
	5,516,469	05/96	Santoh et al.			
	5,576,918	11/96	Bar-Gadda et al.			
	5,581,539	12/96	Horie et al.			
	5,626,941	05/97	Ouano			
	5,635,267	06/97	Yamada et al.			
	5,701,288	12/97	Seong			
↓	5,723,033	03/98	Weiss			
/PWH/	5,739,972	04/98	Smith et al.			

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	Document Number	Date	Country	Class	Sub-Class	Translation	
						Yes	No
/PWH/	2-10536	01/90	Japan			X	
	2-150325	06/90	Japan			Abstract Only	
	2-244440	09/90	Japan			X	
	6-60441	03/94	Japan			X	
↓	59-193560	11/94	Japan			Abstract Only	
/PWH/	8-147768	06/96	Japan			X	

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U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	SubClass	Filing Date If Appropriate
/PWH/		5,751,510	05/98	Smith et al.	_____	_____	
↓		5,763,037	06/98	Ohtomo et al.	_____	_____	
		5,889,756	03/99	Ichihara et al.	_____	_____	
		5,949,587	09/99	Takamizawa et al.	_____	_____	
		6,183,829	02/01	Daccher et al.	_____	_____	
		6,190,838	02/01	Kerfeld	_____	_____	
/PWH/		6,324,139	11/01	Nakane	_____	_____	
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		Document Number	Date	Country	Class	Sub- Class	Translation Yes No
/PWH/		08-306080	11/96	Japan	_____	_____	X
/PWH/		97097452	04/97	Japan	_____	_____	X
/PWH/		97138981	05/97	Japan	_____	_____	X
/PWH/		WO 00/48172	08/00	WIPO	_____	_____	
OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)							
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